

XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error

FEATURES AND BENEFITS

• Integrated contact current sensing for low to medium current ranges:

\square 0 to 20 A	\square 0 to 50 A
$\Box \pm 20 \text{ A}$	$\Box \pm 50 \text{ A}$
\square 0 to 30 A	\square 0 to 65 A
$\Box \pm 30 \text{ A}$	□ ±65 A

- Integrated current carrying conductor (CCC)
- · Linear analog output voltage
- Total error output $\leq \pm 1.0\%$ FS
- 1 MHz bandwidth
- Response time: ~300 ns
- UL/IEC 62368-1 and UL1577 certification
 Rated isolation voltage: 4 kV_{RMS}
 Working voltage for basic isolation: 701 V_{RMS}
 Working voltage for reinforced isolation: 344 V_{RMS}
- IEC 61000-4-5 certified
- Low noise: 9.5 to 19.0 mA_{RMS} @ $f_{BW} = 100 \text{ kHz}$
- Supply voltage: 3.0 to 3.6 V
- Filter function to reduce noise on output pin
- Immunity to common mode fields: -54 dB
- Overcurrent detection
- □ Out of range currents
- AEC-Q100 grade 1
- 8-lead SOIC package







DESCRIPTION

The CT427 is a high bandwidth and ultra-low noise integrated contact current sensor that uses Allegro patented XtremeSenseTM TMR technology to enable high accuracy current measurements for many consumer, enterprise, and industrial applications. The device supports eight current ranges where the integrated current carrying conductor (CCC) will handle up to 65 A of current and generates a current measurement as a linear analog output voltage. The device achieves a total output error of less than $\pm 1.0\%$ full-scale (FS).

The device has a 300 ns output response time while the current consumption is \sim 6.0 mA and is immune to common mode fields. The CT427 has an integrated overcurrent detection (OCD) circuitry to identify out of range currents (OCD) with the result output to the fault-bar (FLT) pin. The FLT is an open drain, active low digital signal that is activated by the CT427 to alert the microcontroller that a fault condition has occurred.

The CT427 is offered in an industry-standard 8-lead SOIC package that is green and RoHS compliant.

APPLICATIONS

- Solar/power inverters
- Power utility meter
- UPS, SMPS, and telecom power supplies
- Power utility mete Overcurrent fault
 - rotection Overcurrent
- Motor control **PACKAGE**:

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8-lead SOIC

Not to scale

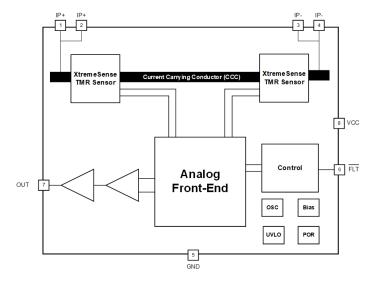


Figure 1: CT427 Functional Block Diagram for 8-lead SOIC Package

SELECTION GUIDE

Part Number	Current Range (I _{PMAX}) (A)	Sensitivity (mV/A)	Operating Temperature Range (°C)	Package	Packing
CT427-HSN820MR	±20	50			
CT427-HSN830MR	±30	33.3			
CT427-HSN850MR	±50	20			
CT427-HSN865MR	±65	15.4	40 to 125	8-lead SOIC	Tape and
CT427-HSN820DR	20	100	40 to 125	4.89 mm × 6.00 mm × 1.62 mm	Reel
CT427-HSN830DR	30	66.7			
CT427-HSN850DR	50	40			
CT427-HSN865DR	65	30.8			
AEC-Q100 GRADE 1					
CT427-ASN820MR	±20	50			
CT427-ASN830MR	±30	33.3			
CT427-ASN850MR	±50	20			
CT427-ASN865MR	±65	15.4	Grade 1	8-lead SOIC	Tape and
CT427-ASN820DR	20	100	-40 to 125	4.89 mm × 6.00 mm × 1.62 mm	Reel
CT427-ASN830DR	30	66.7]		
CT427-ASN850DR	50	0 40			
CT427-ASN865DR	65	30.8]		

EVALUATION BOARD SELECTION GUIDE

Part Number	Current Range (A)	Operating Temperature Range (°C)
CTD427-20DC	0 to 20	
CTD427-20AC	±20	
CTD427-30DC	0 to 30	
CTD427-30AC	±30	-40 to 125
CTD427-50DC	0 to 50	-4010125
CTD427-50AC	±50	
CTD427-65DC	0 to 65	
CTD427-65AC	±65	

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ABSOLUTE MAXIMUM RATINGS [1]

Characteristic	Symbol	Notes	Rating	Unit
Supply Voltage Strength	V _{CC}		-0.3 to 6.0	V
Analog Input/Output Pins Maximum Voltage	V _{I/O}		-0.3 to V _{CC} + 0.3 ^[2]	V
Current Carrying Conductor Maximum Current	I _{CCC(MAX)}	T _A = 25°C	70	А
Dielectric Surge Strength Test Voltage	V _{SURGE}	IEC 61000-4-5: Tested ± 5 Pulses at 2/60 seconds, 1.2 µs (rise) and 50 µs (width)	6.0 (min)	kV
Surge Strength Test Current	I _{SURGE}	Tested ±5 Pulses at 3/60 seconds, 8.0 μs (rise) and 20 μs (width)	3.0 (min)	kA
Electro statio Discharge Drate stien Laurel		Human Body Model (HBM) per JESD22-A114	±2.0	kV
Electrostatic Discharge Protection Level	ESD	Charged Device Model (CDM) per JESD22-C101	±0.5	kV
Junction Temperature	TJ		-40 to 150	°C
Storage Temperature	T _{STG}		-65 to 155	°C
Lead Soldering Temperature	TL	10 seconds	260	°C

[1] Stresses exceeding the absolute maximum ratings may damage the CT427 and may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

 $^{[2]}\mbox{The lower of V}_{CC}\mbox{ + }0.3\mbox{ V or }6.0\mbox{ V}.$

RECOMMENDED OPERATING CONDITIONS^[1]

Characteristic	Symbol	Notes	Min.	Тур.	Max.	Unit
Supply Voltage Range	V _{CC}		3.0	3.3	3.6	V
Output Voltage Range	V _{OUT}		0	_	V _{CC}	V
Output Current	I _{OUT}		-	_	±1.0	mA
Operating Ambient Temperature	т	Extended Industrial	-40	25	125	°C
Operating Ambient Temperature	I _A	Automotive	-40	25	125	°C

^[1] The Recommended Operating Conditions table defines the conditions for actual operation of the CT427. Recommended operating conditions are specified to ensure optimal performance to the specifications. Allegro does not recommend exceeding them or designing to absolute maximum ratings.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Value	Unit
Junction-to-Ambient Thermal Resistance	R _{θJA}	Junction-to-ambient thermal resistance is a function of application and board layout and is determined in accordance to JEDEC standard JESD51 for a four (4) layer 2s2p FR-4 printed circuit board (PCB) with 2 oz. of copper (Cu) and 4 oz. of copper (Cu) or more for 65 A. Special attention must be paid not to exceed junction temperature $T_{J(MAX)}$ at a given ambient temperature T_A .	25	°C/W
Junction-to-Case Thermal Resistance	$R_{ extsf{ heta}JC}$		15	°C/W



ISOLATION RATINGS

Characteristic	Symbol	Notes	Rating	Unit
Rated Isolation Voltage	N	Agency Tested per IEC 62368 ^[1] for 60 seconds. Production Tested at V _{ISO} for 1 second per IEC 62368.	4.0	kV _{RMS}
Raled isolation voltage	V _{ISO}	Agency Tested per UL1577 for 60 seconds. Production Tested at V _{ISO} for 1 second per UL1577.	4.0	kV _{RMS}
Working Voltage for Basic Isolation	V	Tested per IEC 62368 ^[1] .	991	V _{PK}
Working voltage for basic isolation	V _{WORK_ISO}		701	V _{RMS}
Working Voltage for Deinferend Indiation	V _{WORK_RI}	Tested per IEC 62368 ^[1] .	487	V _{PK}
Working Voltage for Reinforced Isolation			344	V _{RMS}
Creepage Distance	D _{CR}	Minimum distance along package body from IP pins to I/O pins.	4.96	mm
Clearance Distance	D _{CL}	Minimum distance through air from IP pins to I/O pins.	4.63	mm
Distance Through Isolation	D _{ISO}	Minimum internal distance through isolation	110	μm
Comparative Tracking Index	СТІ	Material Group II	400 to 599	V

^[1] IEC 62368 is the succeeding standard to IEC 60950-1 (Edition 2) for isolation testing specifications and as such it will be compliant to the latter standard.

APPLICATION DIAGRAM

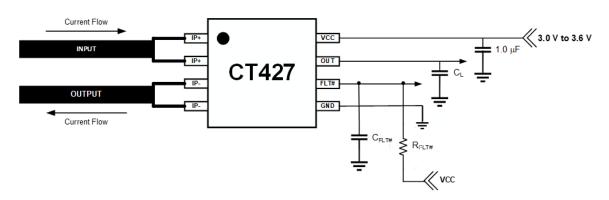


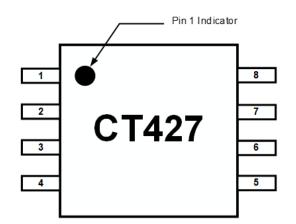
Figure 2: CT427 Application Block Diagram

Table 1: Recommended External Components

Component	Description	Vendor and Part Number	Parameter	Min.	Тур.	Max.	Unit
C _{BYP}	1.0 µF, X5R or Better	Murata GRM155C81A105KA12	C1	-	1.0	-	μF
C _{FLT#}	1.0 µF, X5R or Better	Murata GRM0335C1E102JA01	C2	_	1.0	_	nF
R _{FLT#}	10 kΩ Pull-Up Resistor	Various	R1	_	10	_	kΩ



PINOUT DIAGRAM AND TERMINAL LIST





Terminal List

Number	Name	Function
1, 2	IP+	Input primary conductor (positive).
3, 4	IP-	Output primary conductor (negative).
5	GND	Ground.
6	FLT	Active low output fault signal (open drain output) to indicate that the following parameters are outside of normal operational bounds: • Overcurrent Detection • UVLO If not used, then a 1.0 nF capacitor must be connected from the pin to ground.
7	OUT	Analog output voltage that represents the measured current.
8	VCC	Supply voltage.



ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
POWER SUPPLIES				· · · · · · · · · · · · · · · · · · ·		
Supply Current	I _{CC}	f _{BW} = 1 MHz, no load, I _P = 0 A	-	6.0	9.0	mA
OUT Maximum Drive Capability ^[1]	I _{OUT}	OUT covers 10% to 90% of V _{CC} span	-1.0	_	+1.0	mA
OUT Capacitive Load ^[1]	C _{L_OUT}		-	-	100	pF
OUT Resistive Load ^[1]	R _{L_OUT}		-	100	_	kΩ
Primary Conductor Resistance [1]	R _{IP}		-	0.5	_	mΩ
Power Supply Rejection Ratio ^[1]	PSRR		-	35	-	dB
Sensitivity Power Supply Rejection Ratio ^[1]	SPSRR		-	35	-	dB
Offset Power Supply Rejection Ratio [1]	OPSRR		-	40	-	dB
ANALOG OUTPUT (OUT)						
OUT Voltage Linear Range, Typical	V _{OUT}	$V_{SIG_{AC}} = \pm 1.00 \text{ V}, V_{SIG_{DC}} = +2.00 \text{ V}$	0.65	-	2.65	V
Output High Saturation Voltage	V _{OUT_SAT}	V_{OUT} , $T_A = 25^{\circ}C$	V _{CC} - 0.30	V _{CC} - 0.25	-	V
Common Mode Field Rejection Ratio [1]	CMFRR		-	-54	-	dB
Common Mode Field Rejection Ratio	GIVIETAR		-	0.5	_	mA/G
FAULT OUTPUT (FLT)						
FLT Voltage Low	V _{FLT#_OL}	I _{FLT#_OUT} ≤ 20 mA	0	_	0.5	V
High-Impedance Output Leakage Current	$I_{LEAK_FLT\#}$	V _{FLT#_OH} = V _{CC}		5	_	μA
FLT Pull-Up Resistor	R _{PU}		-	100	_	kΩ
TIMINGS						
Power-On Time ^[1]	t _{ON}	V _{CC} ≥ 2.50 V	_	100	200	μs
Rise Time ^[1]	t _{RISE}	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 100 \text{ pF}$		200	_	ns
Response Time ^[1]	t _{RESPONSE}	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 100 \text{ pF}$		300	_	ns
Propagation Delay ^[1]	t _{DELAY}	$I_P = I_{RANGE(MAX)}, T_A = 25^{\circ}C, C_L = 100 \text{ pF}$	-	250	_	ns
FLT Response Time	t _{FLT#}		-	250	_	ns
PROTECTION						
Undervoltage Lockout	V _{UVLO}	Rising V _{DD}		2.50	_	V
ondervoltage Lockout	♥ UVLO	Falling V _{DD}		2.45	_	V
UVLO Hysteresis	V _{UV_HYS}		-	50	_	mV
Overcurrent Detection (OCD) for DC	Tee	Rising I _P	_	1.1 × I _{RANGE(MAX)}	_	A
Current (Unipolar)	I _{OCD_U}	Falling I _P	_	0.9 × I _{RANGE(MAX)}	-	A
Overcurrent Detection (OCD) for AC	т	Rising I _P	-	1.1 × I _{RANGE(MAX)}	-	A
Current (Bipolar)	I _{OCD_B}	Falling I _P	-	0.9 × I _{RANGE(MAX)}	_	A
Overcurrent Detection Hysteresis	I _{OCD_HYS}		-	0.2 × I _{RANGE(MAX)}	_	А



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ELECTRICAL CHARACTERISTICS

 V_{CC} = 3.3 V, T_{A} = 25°C, and C_{BYP} = 1.0 μF (unless otherwise specified)

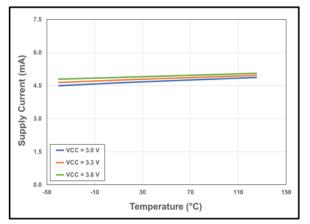


Figure 4: CT427 Supply Current vs. Temperature vs. Supply Voltage

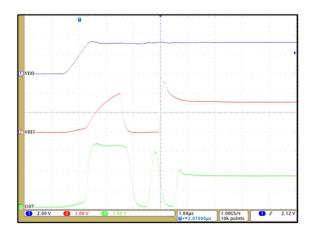


Figure 5: CT427 Startup Waveforms for V_{OQ} = 1.65 V (AC Current)



ELECTRICAL CHARACTERISTICS (continued) V_{CC} = 3.3 V, T_A = 25°C, and C_{BYP} = 1.0 µF (unless otherwise specified)

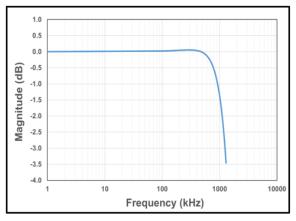


Figure 6: CT427 Bandwidth with C_{FILTER} = 1.0 pF

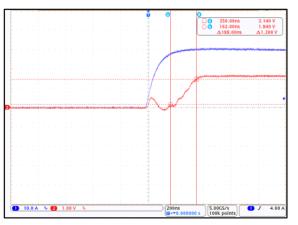


Figure 8: CT427 Rise Time; $I_P = 30 A_{PK}$ and $C_L = 100 pF$

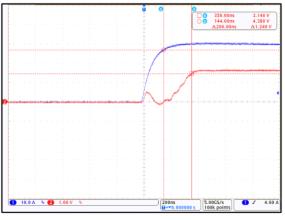


Figure 7: CT427 Response Time; I_P = 30 A_{PK} and $C_L = 100 \text{ pF}$

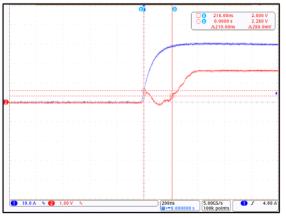


Figure 9: CT427 Propagation Delay; $I_P = 30 A_{PK}$ and $C_L = 100 pF$



ELECTRICAL CHARACTERISTICS (continued) V_{CC} = 3.3 V, T_A = 25°C, and C_{BYP} = 1.0 µF (unless otherwise specified)

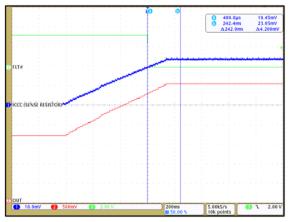
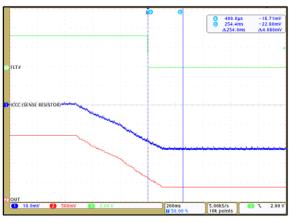


Figure 10: CT427 OCD enabled at 110% of 30 A_{PK} and FLT# is Low



FLT# is Low

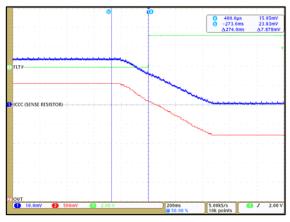


Figure 11: CT427 OCD disabled at 90% of 30 A_{PK} and FLT# is High

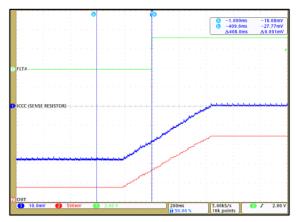


Figure 12: CT427 OCD enabled at -110% of -30 A_{PK} and Figure 13: CT427 OCD disabled at -90% of -30 A_{PK} and FLT# is High



CT427-xSN820DR: 0 to 20 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Current Range	I _{RANGE}		0	-	20	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	0.645	0.650	0.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	100	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	9.5	_	mA _{RMS}
OUT ACCURACY PERFORMANC	E					
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	_	±0.7	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.1	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
			-	±5.2	_	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_P = 0 A, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.3	_	% FS
LIFETIME DRIFT			<u>~</u>			
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	_	±1.0	_	% FS



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4.00 -40°C 3.00 +25°C Total Output Error (% FS) +125°C 2.00 1.00 0.00 -1.00 -2.00 -3.00 -4.00 0.0 2.5 5.0 7.5 10.0 12.5 15.0 17.5 20.0 Current (A)



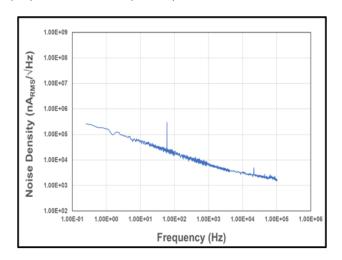


Figure 15: Noise Density vs. Frequency

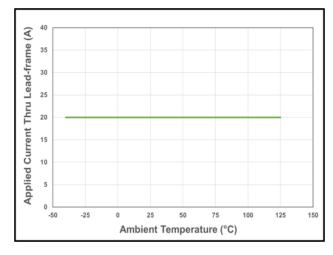


Figure 16: CT427 Current Derating Curve for 20 A_{DC}



CT427-xSN820MR: ±20 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	Symbol Test Conditions		Тур.	Max.	Unit
Current Range	I _{RANGE}		-20	-	20	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	1.645	1.650	1.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	50	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	11.0	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	-	±0.5	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.1	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.3	_	% FS
			-	±7.9	_	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±0.4	_	% FS
LIFETIME DRIFT			·			
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	-	±1.0	_	% FS







4.00 -40°C 3.00 +25°C Total Output Error (% FS) +125°C 2.00 1.00 0.00 -1.00 -2.00 -3.00 -4.00 -20.0 -15.0 -10.0 -5.0 0.0 5.0 10.0 15.0 20.0 Current (A)



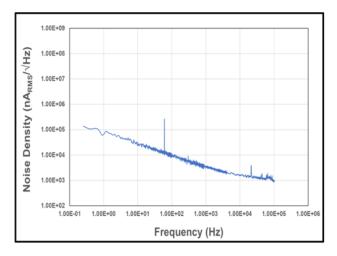


Figure 18: Noise Density vs. Frequency

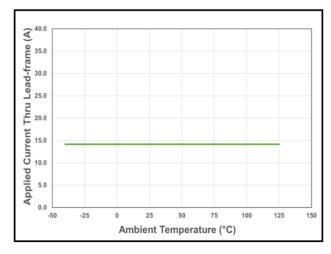


Figure 19: CT427 Current Derating Curve for 20 A_{PK} (14.1 A_{DC})



CT427-xSN830DR: 0 to 30 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	ymbol Test Conditions		Тур.	Max.	Unit
Current Range	I _{RANGE}		0	-	30	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	0.645	0.650	0.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	66.7	-	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB, C _{FILTER} = 5 pF	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	10.0	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	-	±0.7	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_P = I_{P(MAX)}$, $T_A = -40^{\circ}C$ to 125°C	-	±0.1	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_P = I_{P(MAX)}$, $T_A = -40^{\circ}C$ to 125°C	-	±0.3	_	% FS
			-	±4.4	_	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_P = 0 A, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.2	_	% FS
LIFETIME DRIFT					·	
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	-	±1.0	_	% FS

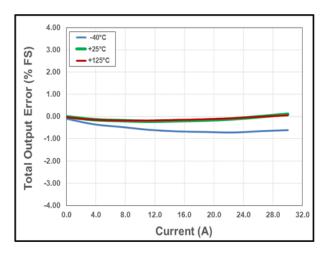
 $\ensuremath{^{[1]}}$ Guaranteed by design and characterization; not tested in production.



XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error



 V_{CC} = 3.3 V, T_A = 25°C, and C_{BYP} = 1.0 μ F (unless otherwise specified)





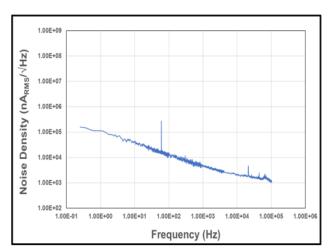


Figure 21: Noise Density vs. Frequency

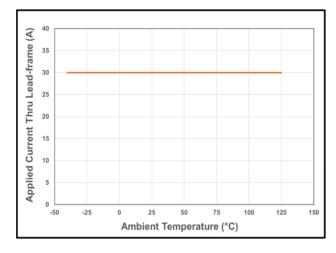


Figure 22: CT427 Current Derating Curve for 30 A_{DC}



CT427-xSN830MR: ±30 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

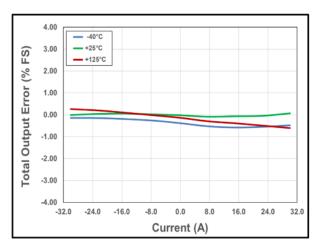
Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Current Range	I _{RANGE}		-30	_	30	A
Voltage Output Quiescent	V _{OQ}	$T_A = 25^{\circ}C, I_P = 0 A$	1.645	1.650	1.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	33.3	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB, C _{FILTER} = 5 pF	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	_	12.5	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	_	±0.5	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.1	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.3	_	% FS
Offer at 1 (alter and [1]			_	±6.6	_	mV
Offset Voltage [1]	V _{OFFSET}	$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±0.3	_	% FS
LIFETIME DRIFT						
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	_	±1.0	_	% FS



XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error



 V_{CC} = 3.3 V, T_A = 25°C, and C_{BYP} = 1.0 µF (unless otherwise specified)





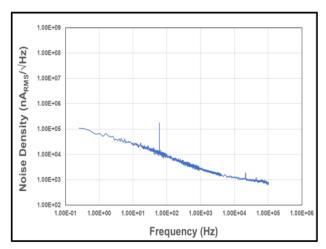


Figure 24: Noise Density vs. Frequency

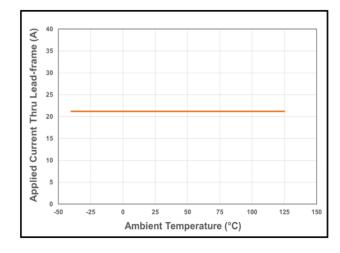


Figure 25: CT427 Current Derating Curve for 30 A_{PK} (21.2 A_{DC})



CT427-xSN850DR: 0 to 50 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	Symbol Test Conditions		Тур.	Max.	Unit
Current Range	I _{RANGE}		0	_	50	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	0.645	0.650	0.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	40	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	11.0	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	-	±1.0	±1.5	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.2	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.7	_	% FS
Offered 1 / alterna [1]			-	±8.8	_	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±0.4	_	% FS
LIFETIME DRIFT						
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	_	±1.0	_	% FS

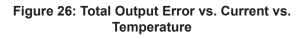
 $\ensuremath{^{[1]}}$ Guaranteed by design and characterization; not tested in production.



XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error



4.00 -40°C 3.00 +25°C FS) +125°C Total Output Error (% 2.00 1.00 0.00 -1.00 -2.00 -3.00 -4.00 28.0 35.0 42.0 0.0 7.0 14.0 21.0 49.0 56.0 Current (A)



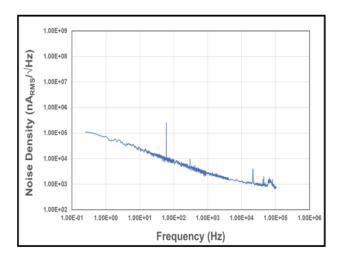


Figure 27: Noise Density vs. Frequency

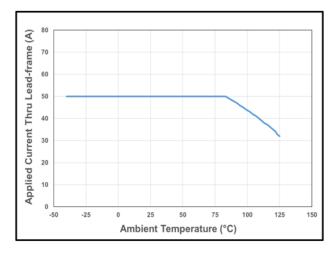


Figure 28: CT427 Current Derating Curve for 50 A_{DC}



CT427-xSN850MR: ±50 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

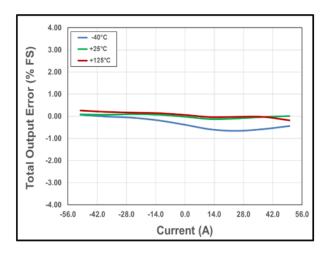
Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Current Range	I _{RANGE}		-50	_	50	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	1.645	1.650	1.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	20	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	_	19.0	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	_	±0.5	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.1	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.5	_	% FS
		$T = 0.0$ $T = -40^{\circ}0.45$ 405°0	-	±6.0	_	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	_	±0.3	_	% FS
LIFETIME DRIFT						й
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	_	±1.0	_	% FS







 V_{CC} = 3.3 V, T_A = 25°C, and C_{BYP} = 1.0 µF (unless otherwise specified)





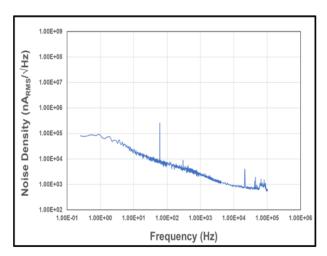


Figure 30: Noise Density vs. Frequency

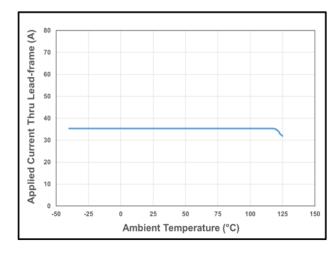


Figure 31: CT427 Current Derating Curve for 50 A_{PK} (35.4 A_{DC})



CT427-xSN865DR: 0 to 65 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

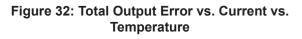
Characteristics	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Current Range	I _{RANGE}		0	-	65	A
Voltage Output Quiescent	V _{OQ}	$T_{A} = 25^{\circ}C, I_{P} = 0 A$	0.645	0.650	0.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	30.8	-	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB, C _{FILTER} = 5 pF	-	1.0	-	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	11.5	-	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	-	±1.0	±1.5	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
Offered Marken [1]			-	±3.0	-	mV
Offset Voltage ^[1]	V _{OFFSET}	$I_{P} = 0 \text{ A}, T_{A} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C}$	-	±0.1	-	% FS
LIFETIME DRIFT						
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	-	±1.0	_	% FS

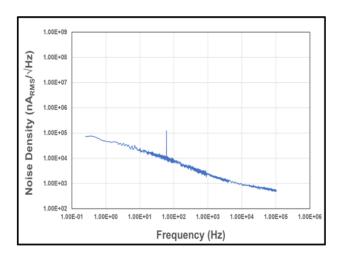


XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error



4.00 -40°C 3.00 +25°C Total Output Error (% FS) +45°C 2.00 1.00 0.00 -1.00 -2.00 -3.00 -4.00 0.0 9.0 18.0 27.0 36.0 45.0 54.0 63.0 72.0 Current (A)







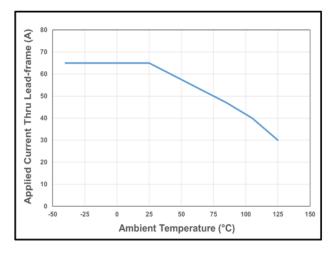


Figure 34: CT427 Current Derating Curve for 65 A_{DC}



CT427-xSN865MR: ±65 A – ELECTRICAL CHARACTERISTICS: Valid for V_{CC} = 3.0 to 3.6 V, C_{BYP} = 1.0 µF, and T_A = -40°C to 125°C, typical values are V_{CC} = 3.3 V and T_A = 25°C, unless otherwise specified

Characteristics	Symbol	Symbol Test Conditions		Тур.	Max.	Unit
Current Range	I _{RANGE}		-65	-	65	A
Voltage Output Quiescent	V _{OQ}	$T_A = 25^{\circ}C, I_P = 0 A$	1.645	1.650	1.655	V
Sensitivity	S	$I_{RANGE(MIN)} < I_{P} < I_{RANGE(MAX)}$	-	15.4	_	mV/A
Bandwidth ^[1]	f _{BW}	Small Signal = –3 dB, C _{FILTER} = 5 pF	-	1.0	_	MHz
Noise ^[1]	e _N	T _A = 25°C, f _{BW} = 100 kHz	-	19.0	_	mA _{RMS}
OUT ACCURACY PERFORMANCE						
Total Output Error	E _{OUT}	$I_{P} = I_{P(MAX)}$	_	±0.5	±1.0	% FS
Non-Linearity Error ^[1]	E _{LIN}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.2	_	% FS
Sensitivity Error ^[1]	E _{SENS}	$I_{P} = I_{P(MAX)}, T_{A} = -40^{\circ}C \text{ to } 125^{\circ}C$	-	±0.3	_	% FS
Off and Maller and [1]			-	±4.0	_	mV
Offset Voltage [1]	V _{OFFSET}	$I_P = 0 A, T_A = -40^{\circ}C \text{ to } 125^{\circ}C$	_	±0.1	_	% FS
LIFETIME DRIFT						
Total Output Error Lifetime Drift ^[1]	E _{TOT_DRIFT}	$I_{P} = I_{P(MAX)}$	_	±1.0	_	% FS

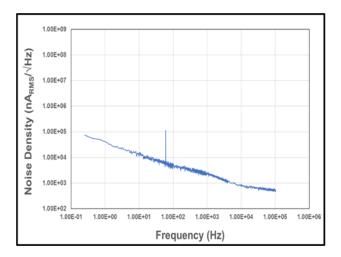


XtremeSense[™] TMR Current Sensor with Ultra-Low Noise and <0.7% Total Error



4.00 -40°C FS) 3.00 +25°C +45°C VOUT - VREF Error (% 2.00 1.00 0.00 -1.00 -2.00 -3.00 -4.00 -68.0 -51.0 -34.0 -17.0 0.0 17.0 34.0 51.0 68.0 Current (A)







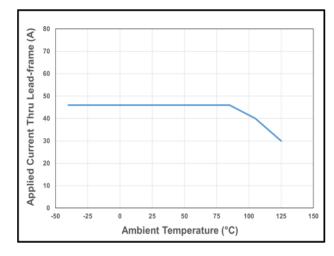


Figure 37: CT427 Current Derating Curve for 65 A_{PK} (46.0 A_{DC})



FUNCTIONAL DESCRIPTION

Overview

The CT427 is a high accuracy contact current sensor with an integrated current-carrying conductor that handles up to 65 A. It has high sensitivity and a wide dynamic range with excellent accuracy (low total output error) across temperature. This current sensor supports eight current ranges:

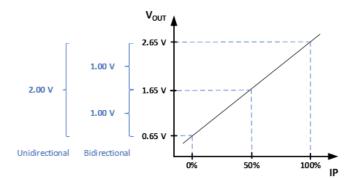
•	0 to 20 A	•	0 to 50 A
•	±20 A	٠	$\pm 50 A$
•	0 to 30 A	٠	0 to 65 A
•	±30 A	•	±65 A

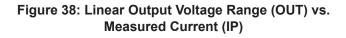
When current is flowing through the current-carrying conductor, the XtremeSense TMR sensors inside the chip senses the field which in turn generates differential voltage signals that then goes through the Analog Front-End (AFE) to output a current measurement with less than $\pm 1.0\%$ full-scale total output error (E_{OUT}).

The chip is designed to enable a fast response time of 300 ns for the current measurement from the OUT pin as the bandwidth for the CT427 is 1.0 MHz. Even with a high bandwidth, the chip consumes a minimal amount of power.

Linear Output Current Measurement

The CT427 provides a continuous linear analog output voltage which represents the current measurement. The output voltage range of OUT is from 0.65 to 2.65 V with a V_{OQ} of 0.65 V and 1.65 V for unidirectional and bidirectional currents, respectively. Figure 38 illustrates the output voltage range of the OUT pin as a function of the measured current.





Sensitivity

Sensitivity (S) is a change in the CT427 output in response to a change in 1 A of current flowing through the current-carrying conductor. It is defined by the product of the magnetic circuit sensitivity (G/A, where 1.0 G = 0.1 mT) and the chip linear amplifier gain (mV/G). Therefore, the result of this gives a sensitivity unit of mV/A. The CT427 is factory-calibrated to optimize the sensitivity for the full scale of the device dynamic range.

Total Output Error

The Total Output Error (E_{OUT}) is the maximum deviation of the sensor output from the ideal sensor transfer curve over the full temperature range relative to the sensor full scale.

The Total Output Error is measured by performing a full-scale primary current (IP) sweep and measuring V_{OUT} at multiple points.

$$E_{OUT} = 100 * \frac{\max\left(V_{OUT_{IDEAL}}(l) - V_{OUT}(l)\right)}{F.S.}$$

The Ideal Transfer Curve is calculated based on datasheet parameters as described below.

$$V_{OUT_{IDEAL}}(I_P) = V_{OQ} + S * I_P$$

 E_{OUT} incorporates all sources of error and is a function of the sensed current (I_P) from the current sensor.

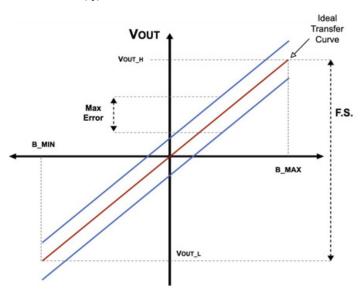


Figure 39: Total Output Error (E_{OUT}) vs. Sensed Current (I_P)



The CT427 achieves a total output error (E_{OUT}) that is less than $\pm 1.0\%$ of Full-Scale (FS) over supply voltage and temperature. It is designed with innovative and proprietary TMR sensors and circuit blocks to provide very accurate current measurements regardless of the operating conditions.

Sensitivity Error

The sensitivity error (E_{SENS}) is the sensitivity temperature drift error for unipolar or DC current. It is calculated using the equation below:

$$E_{SENS} = 100 \times \left(\frac{S_{MEASURED}}{S} - 1\right)$$

For bipolar or AC current, the $\mathrm{E}_{\mathrm{SENS}}$ is calculated by dividing the equation by 2.

Power-On Time (t_{ON})

Power-On Time (t_{ON}) of 100 µs is the amount of time required by CT427 to start up, fully power the chip, and becoming fully operational from the moment the supply voltage is applied to it. This time includes the ramp-up time and the settling time (within 10% of steady-state voltage under an applied magnetic field) after the power supply has reached the minimum V_{CC}.

Response Time (t_{RESPONSE})

Response Time ($t_{RESPONSE}$) of 300 ns for the CT427 is the time interval between the following terms:

- 1. When the primary current signal reaches 90% of its final value,
- 2. When the chip reaches 90% of its output corresponding to the applied current.

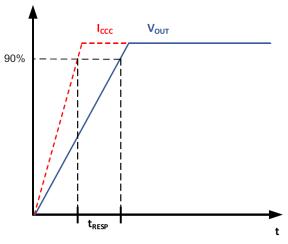


Figure 40: CT427 Response Time Curve

Rise Time (t_{RISE})

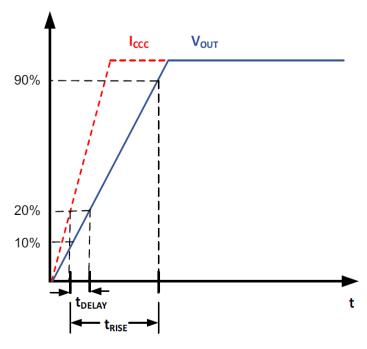
Rise Time (t_{RISE}) is the time interval of when it reaches 10% and 90% of the full-scale output voltage. The t_{RISE} of the CT427 is 200 ns.

Propagation Delay (t_{DELAY})

Propagation Delay (t_{DELAY}) is the time difference between these two events:

- 1. When the primary current reaches 20% of its final value
- 2. When the chip reaches 20% of its output corresponding to the applied current.

The CT427 has a propagation delay of 250 ns.





Undervoltage Lockout (UVLO)

The Undervoltage Lockout protection circuitry of the CT427 is activated when the supply voltage (V_{CC}) falls below 2.45 V. The CT427 remains in a low quiescent state until V_{CC} rises above the UVLO threshold (2.50 V). In this condition where V_{CC} is less than 2.45 V and UVLO is triggered, the output from the CT427 is not valid, and the FLT pin will go low. Once V_{CC} rises above 2.50 V then the UVLO is cleared, and the FLT pin will be high



Immunity to Common Mode Fields

The CT427 is housed in a custom plastic package that uses a U-shaped leadframe to reduce the common mode fields generated as current flows through the current-carrying conductor. With the U-shaped leadframe, the stray fields cancel one another thus reducing electromagnetic interference (EMI).

Also, a good PCB layout of the CT427 will optimize performance and reduce EMI. See the Applications Information section in this datasheet for recommendations on PCB layout.

Creepage and Clearance

Two important terms as it relates to isolation provided by the package are: creepage and clearance. Creepage is defined as the shortest distance across the surface of the package from one side the leads to the other side of the leads. The definition for clearance is the shortest distance between the leads of opposite side through the air. Figure 42 illustrates the creepage and clearance for the SOIC-8 package of the CT427.

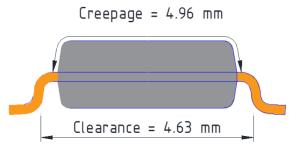


Figure 42: The Creepage and Clearance for the CT427 SOIC-8 package

Application

The CT427 is an integrated contact current sensor that can be used in many applications from measuring current in power supplies to motor control to overcurrent fault protection. It is a plugand-play solution in that no calibration is required, and it outputs to a microcontroller a simple linear analog output voltage which corresponds to a current measurement value.

It is designed to support an operating voltage range of 3.0 to 3.6 V, but it is ideal to use a 3.3 V power supply where the output tolerance is less than $\pm 5\%$.

Bypass Capacitor

A single 1.0 μ F capacitor is needed for the VCC pin to reduce the noise from the power supply and other circuits. This capacitor should be placed as close as possible to the CT427 to minimize inductance and resistance between the two devices.

FLT Resistor and Capacitor

For the CT427, the \overline{FLT} pin is an open drain output. It requires a pull-up resistor value of 100 k Ω to be connected from the pin to V_{CC} and also a 1.0 nF capacitor to be connected from the pin to ground.

If the $\overline{\text{FLT}}$ pin function is not needed in the application, then a 1.0 nF capacitor must be connected from the pin to ground.

Fault# Interrupt (FLT)

The CT427 generates an active low digital fault signal via the \overline{FLT} pin to interrupt the microcontroller to indicate a fault event has been triggered. It is an open drain output and requires a pull-up resistor with a value of 100 k Ω tied to VCC and a 1.0 nF capacitor is connected to ground. A fault signal will interrupt the host system for these events:

- OCD
- UVLO

The \overline{FLT} signal will be asserted low whenever one of the above fault events occur. In the case of an UVLO event, the \overline{FLT} pin will stay low until the fault is cleared and then go high.

If the \overline{FLT} is not used, then a 1.0 nF capacitor must be connected from the pin to ground.



Recommended PCB Layout

Since the CT427 can measure up to 65 A of current, special care must be taken in the printed circuit board (PCB) layout of the CT427 and the surrounding circuitry. It is recommended that the CCC pins be connected to as much copper area as possible. It is also recommended that 2 oz. or heavier copper be used for PCB traces when the CT427 is used to measure up to 30 A of current. Additional layers of the PCB should also be used to carry current and be connected using the arrangement of vias. Figure 43 and Figure 44 show the recommended the PCB layout for the 20 A and 30 A variants of CT427. For the 65 A variant, it is recommended that 4 oz. of copper be used for the PCB traces.

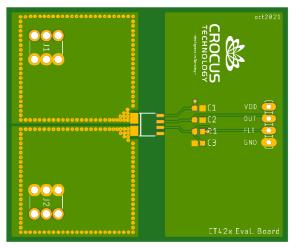


Figure 43: Recommended PCB Layout (Top Layer) for the 20 A to 65 A variants of the CT427

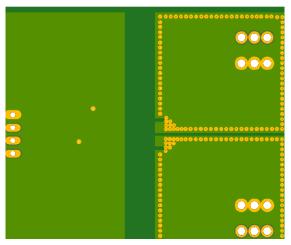


Figure 44: Recommended PCB Layout (Bottom Layer) for the 20 A to 65 A variants of the CT427





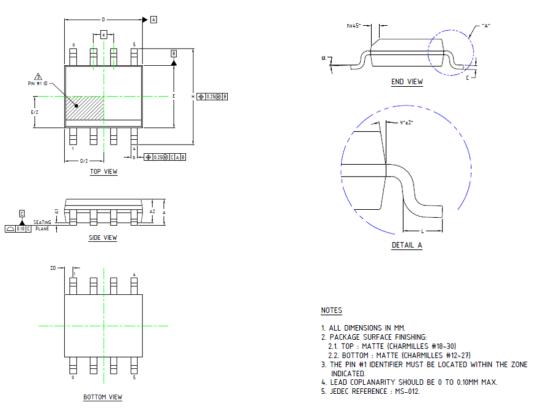


Figure 45: SOIC-8 Package Drawing and Dimensions

Table 2: CT427 SOIC-	8 Package Dimensions
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Symbol		Dimensions in Millimeters (mm)			
Symbol	Min.	Тур.	Max.		
A1	0.10	0.18	0.25		
b	0.36	0.41	0.46		
С	0.19	0.22	0.25		
D	4.80	4.89	4.98		
E	3.81	3.90	3.99		
е	1.27 BSC				
Н	5.80	6.00	6.20		
h	0.25	0.37	0.50		
L	0.41	-	1.27		
A	1.52	1.62	1.72		
α	0°	0° – 8°			
ZD		0.53 REF			
A2	1.37	1.47	1.57		



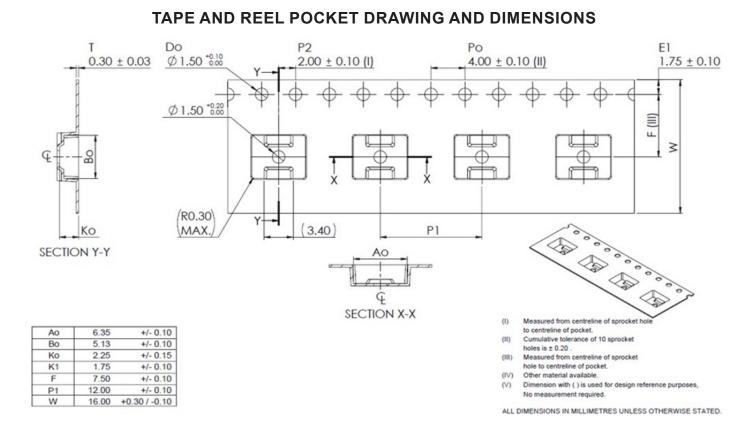


Figure 46: Tape and Pocket Drawing for SOIC-8 Package



PACKAGE INFORMATION

Table 3: CT427 Package Information

Part Number	Package Type	# of Leads	Package Quantity	Lead Finish	MSL Rating ^[2]	Operating Temperature (°C) ^[3]	Device Marking ^[4]
CT427-HSN820DR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S820DR YYWWLL
CT427-ASN820DR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S820DR YYWWLL
CT427-HSN820MR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S820MR YYWWLL
CT427-ASN820MR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S820MR YYWWLL
CT427-HSN830DR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S830DR YYWWLL
CT427-ASN830DR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S830DR YYWWLL
CT427-HSN830MR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S830MR YYWWLL
CT427-ASN830MR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S830MR YYWWLL
CT427-HSN850DR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S850DR YYWWLL
CT427-ASN850DR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S850DR YYWWLL
CT427-HSN850MR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S850MR YYWWLL
CT427-ASN850MR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S850MR YYWWLL
CT427-HSN865DR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S865DR YYWWLL
CT427-ASN865DR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S865DR YYWWLL
CT427-HSN865MR	SOIC	8	2000	Sn	3	-40 to 125	CT427 S865MR YYWWLL
CT427-ASN865MR	SOIC	8	2000	Sn	3	-40 to 125	CT427A S865MR YYWWLL

[1] RoHS is defined as semiconductor products that are compliant to the current EU RoHS requirements. It also will meet the requirement that RoHS substances do not exceed 0.1% by weight in homogeneous materials. Green is defined as the content of chlorine (CI), bromine (Br), and antimony trioxide based flame retardants satisfy JS709B low halogen requirements of ≤ 1,000 ppm.

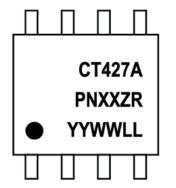
^[2] MSL Rating = Moisture Sensitivity Level Rating as defined by JEDEC standard classifications.

^[3] Package will withstand ambient temperature range of -40°C to 125°C and storage temperature range of -65°C to 150°C.

^[4] Device Marking for CT427 is defined as CT427 S8xxZR YYWWLL where the first 2 lines = part number, YY = year, WW = work week, and LL = lot code.



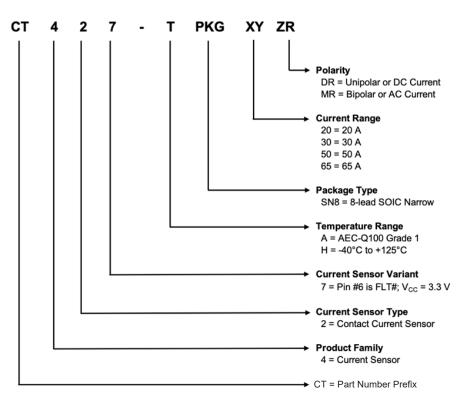
DEVICE MARKING



Row No.	Code	Definition
3	•	Pin 1 Indicator
1	CT427	Allegro Part Number
1	А	AEC-Q100 Qualified
2	Р	Package Type
2	N	Number of Pins
2	XX	Current Range
2	ZR	Polarity
3	ΥY	Calendar Year
3	WW	Work Week
3	LL	Lot Code

Table 4: CT427 Device Marking Definition for 8-lead SOIC Package

Eiguro /	47: CT427	Dovico	Marking	for 9	load	Dackaga
rigule 4	4/. CI4Z/	Device	warking	101 0	-leau	rackaye



PART ORDERING NUMBER LEGEND



Revision History

Number	Date	Description
2	November 2, 2023	Document rebranded and minor editorial updates

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 CT427-HSN865DR
 CT427-H